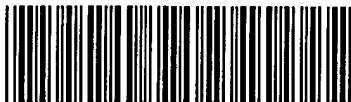


Search Notes

Application/Control No.

10/672,151

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

JACOBS ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	710	7/18/2005	BT
438	712	7/18/2005	BT
438	714	7/18/2005	BT
438	723	7/18/2005	BT
438	724	7/18/2005	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using USPAT, US- PGPUB, JPO, EPO, DERWENT	7/18/2005	BT